



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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| Inventor: | Keiji Yada, et al |) Group Art No.: 2882 |
| | |) |
| Application No: | 10/719,008 |) Examiner: Keaney, Elizabeth M |
| | |) |
| Filed: | 11/21/2003 |) Re: Office Action Response |
| | |) |
| For: | "X-Ray Microscopic Inspection Apparatus" |) Our Ref: B-5309 621525-5 |
| | |) |
| | |) Date: November 14, 2005 |

AMENDMENT AND RESPONSE

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This paper is filed in response to the non-final Office Action mailed on July 14, 2005, a reply to which is due by January 14, 2006. Please amend the above-identified application as described below and consider the following remarks. **All remarks and amendments herein are made without prejudice.**

A fee and a petition for a one-month extension of time are included with this response.

Amendments to the Claims are reflected in the listing of the claims which begins on page 2 of this paper.

Amendments to the Drawings begin on page 5 of this paper and include Attached replacement sheets.

Remarks begin on page 6 of this paper.